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Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/688,873	KANZAWA, HIDEYUKI	
	Examiner	Art Unit	_
25 ((21) #61) # 21(2) (#1) (#1) (#1) (#1) (#1) (#1)	Benjamin T. Liu	2826	

SEARCHED				
Class	Subclass	Date	Examiner	
257	750, 758, 763, 774, 770,734	11/28/2005	BTL	
438	706	11/28/2005	BTL	
257	773	11/28/2005	BTL	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT		
	DATE	EXMR
East search see attached printout	11/28/2005	BTL